



**TRANSISTORS, HIGH POWER, NPN**  
**BASED ON TYPE 2N5154**  
**ESCC Detail Specification No. 5203/010**

**ISSUE 1**  
**October 2002**



|   |                           |  |                    |
|---|---------------------------|--|--------------------|
|  | ESCC Detail Specification |  | PAGE ii<br>ISSUE 1 |
|---|---------------------------|--|--------------------|

### **LEGAL DISCLAIMER AND COPYRIGHT**

European Space Agency, Copyright © 2002. All rights reserved.

The European Space Agency disclaims any liability or responsibility, to any person or entity, with respect to any loss or damage caused, or alleged to be caused, directly or indirectly by the use and application of this ESCC publication.

This publication, without the prior permission of the European Space Agency and provided that it is not used for a commercial purpose, may be:

- copied in whole in any medium without alteration or modification.
- copied in part, in any medium, provided that the ESCC document identification, comprising the ESCC symbol, document number and document issue, is removed.



**europaean space agency  
agence spatiale européenne**

Pages 1 to 19

**TRANSISTORS, HIGH POWER, NPN**

**BASED ON TYPE 2N5154**

**ESA/SCC Detail Specification No. 5203/010**



**space components  
coordination group**

| Issue/Rev. | Date         | Approved by   |                                       |
|------------|--------------|---------------|---------------------------------------|
|            |              | SCCG Chairman | ESA Director General<br>or his Deputy |
| Issue 4    | January 1998 |               |                                       |
|            |              |               |                                       |
|            |              |               |                                       |
|            |              |               |                                       |



**DOCUMENTATION CHANGE NOTICE**

| Rev. Letter | Rev. Date | Reference   | CHANGE Item  | Approved DCR No. |
|-------------|-----------|---|--|------------------|
|             |           | This Issue supersedes Issue 3 and incorporates the changes agreed in the following DCRs:- |  |                  |
|             |           | Cover Page  |  | None             |
|             |           | DCN   |  | None             |
|             |           | Para. 1.2   | : Existing text deleted and new text added   | 221399           |
|             |           | Para. 2   | : Item (c) deleted   | 221399           |
|             |           | Table 1(a)  | : Format amended and Variants 04 and 05 added  | 221399           |
|             |           | Table 1(b)  | : Nos. 1 to 3, "Breakdown" deleted from Characteristics and "(BR)" from Symbol   | 221399           |
|             |           |   | : Nos. 4 and 5, "(Continuous)" added to Characteristics  | 221399           |
|             |           |   | : No. 6, "1" added to Characteristics and Symbol, "Variants 01 to 03" added to existing entry and Variants 04 to 05 entry added. "V <sub>CE</sub> = +40V" deleted from Remarks | 221399           |
|             |           |   | : No. 7, "2" added to Characteristics and Symbol, "Variants 01 to 03" added to existing entry and Variants 04 to 05 entry added  | 221399           |
|             |           |   | : No. 8, "T <sub>amb</sub> or T <sub>case</sub> " added to Remarks   | 221399           |
|             |           |   | : No. 10, Existing Remarks deleted and "Note 2" added  | 221399           |
|             |           |   | : No. 11, New No. 11 added   | 221399           |
|             |           |   | : Notes, New Note 2 added  | 221399           |
|             |           | Figure 1  | : Subtitle added to existing Figure  | 221399           |
|             |           |   | : New Figure 1(b) added  | 221399           |
|             |           | Figure 2  | : Subtitle added to existing Figure  | 221399           |
|             |           |   | : New Figure 2(b) added  | 221399           |
|             |           | Figure 3  | : Notes amended  | 221399           |
|             |           | Para. 4.2.3   | : Existing text deleted and new text added   | 221399           |
|             |           | Para. 4.3.2   | : Existing text deleted and new text added   | 221399           |
|             |           | Para. 4.3.3   | : "Variants 01 to 03" added to existing text and new text for Variants 04 to 05 added  | 221399           |
|             |           | Para. 4.4.1   | : Existing text deleted and new text added   | 221399           |
|             |           | Para. 4.4.2   | : Existing text modified and new text added  | 221399           |
|             |           | Para. 4.5.1   | : Existing text deleted and new text added   | 221399           |
|             |           | Para. 4.5.5   | : Deleted in toto  | 221399           |
|             |           | Para. 4.6.1   | : Second sentence amended  | 221399           |
|             |           | Para. 4.7.2   | : New Para. 4.7.2 added  | 221399           |
|             |           |   | : Existing Para. 4.7.2 renumbered to "4.7.3" and title and text amended  | 221399           |
|             |           | Para. 4.7.3   | : Renumbered as "4.7.5" and title and text amended   | 221399           |
|             |           | Para. 4.7.4   | : New Para. 4.7.4 entry added  | 221399           |
|             |           | Para. 4.7.6   | : New Para. 4.7.6 added  | 221399           |
|             |           | Table 5(a)  | : Entry added  | 221399           |
|             |           | Table 5   | : Title renumbered to "5(b)" and amended   | 221399           |
|             |           |   | : Subtitle added to existing Table and in No. 2, "1" added to Characteristics and Symbol   | 221399           |
|             |           |   | : Table added for Variants 04 to 05  | 221399           |
|             |           | Figure 5(a)   | : Entry added  | 221399           |
|             |           | Figure 5  | : Renumbered to "5(b)" and title amended   | 221399           |
|             |           | Para. 4.8.1   | : Text added to the beginning of the second sentence   | 221399           |
|             |           | Para. 4.8.2   | : Second sentence added  | 221399           |
|             |           | Para. 4.8.3   | : In the second sentence, text amended   | 221399           |
|             |           | Para. 4.8.4   | : Text amended   | 221399           |

**TABLE OF CONTENTS**

|   | <u>Page</u> |
|---|-------------|
| <b>1. <u>GENERAL</u></b>  | <b>5</b>    |
| 1.1 Scope   | 5           |
| 1.2 Component Type Variants   | 5           |
| 1.3 Maximum Ratings   | 5           |
| 1.4 Parameter Derating Information  | 5           |
| 1.5 Physical Dimensions   | 5           |
| 1.6 Functional Diagram  | 5           |
| 1.7 High Temperature Test Precautions   | 5           |
| <b>2. <u>APPLICABLE DOCUMENTS</u></b>   | <b>5</b>    |
| <b>3. <u>TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS</u></b>                     | <b>5</b>    |
| <b>4. <u>REQUIREMENTS</u></b>   | <b>10</b>   |
| 4.1 General   | 10          |
| 4.2 Deviations from Generic Specification   | 10          |
| 4.2.1 Deviations from Special In-process Controls   | 10          |
| 4.2.2 Deviations from Final Production Tests  | 10          |
| 4.2.3 Deviations from Burn-in and Electrical Measurements                                 | 10          |
| 4.2.4 Deviations from Qualification Tests   | 10          |
| 4.2.5 Deviations from Lot Acceptance Tests  | 10          |
| 4.3 Mechanical Requirements   | 10          |
| 4.3.1 Dimension Check   | 10          |
| 4.3.2 Weight  | 10          |
| 4.3.3 Terminal Strength   | 10          |
| 4.4 Materials and Finishes  | 11          |
| 4.4.1 Case  | 11          |
| 4.4.2 Lead Material and Finish  | 11          |
| 4.5 Marking   | 11          |
| 4.5.1 General   | 11          |
| 4.5.2 Lead Identification   | 11          |
| 4.5.3 The SCC Component Number  | 11          |
| 4.5.4 Traceability Information  | 12          |
| 4.6 Electrical Measurements   | 12          |
| 4.6.1 Electrical Measurements at Room Temperature   | 12          |
| 4.6.2 Electrical Measurements at High and Low Temperatures                                | 12          |
| 4.6.3 Circuits for Electrical Measurements  | 12          |
| 4.7 Burn-in Tests   | 12          |
| 4.7.1 Parameter Drift Values  | 12          |
| 4.7.2 Conditions for High Temperature Reverse Bias Burn-in                                | 12          |
| 4.7.3 Conditions for Power Burn-in  | 12          |
| 4.7.4 Electrical Circuit for High Temperature Reverse Bias Burn-in                        | 12          |
| 4.7.5 Electrical Circuit for Power Burn-in  | 12          |
| 4.7.6 Verification of Safe Operating Area   | 12          |
| 4.8 Environmental and Endurance Tests   | 18          |
| 4.8.1 Electrical Measurements on Completion of Environmental Tests                        | 18          |
| 4.8.2 Electrical Measurements at Intermediate Points and on Completion of Endurance Tests | 18          |
| 4.8.3 Conditions for Operating Life Tests   | 18          |
| 4.8.4 Electrical Circuit for Operating Life Tests   | 18          |
| 4.8.5 Conditions for High Temperature Storage Test  | 18          |



**TABLES**

|   | <u>Page</u> |
|---|-------------|
| 1(a) Type Variants  | 6           |
| 1(b) Maximum Ratings  | 6           |
| 2 Electrical Measurements at Room Temperature - d.c. Parameters                         | 13          |
| Electrical Measurements at Room Temperature - a.c. Parameters                           | 14          |
| 3 Electrical Measurements at High and Low Temperatures                                  | 14          |
| 4 Parameter Drift Values  | 16          |
| 5(a) Conditions for High Temperature Reverse Bias Burn-in                               | N/A         |
| 5(b) Conditions for Power Burn-in and Operating Life Tests                              | 16          |
| 6 Electrical Measurements at Intermediate Points and on Completion of Endurance Testing | 19          |

**FIGURES**

|  |     |
|--|-----|
| 1 Parameter Derating Information                                   | 7   |
| 2 Physical Dimensions  | 8   |
| 3 Functional Diagram   | 9   |
| 4 Circuits for Electrical Measurements                             | 15  |
| 5(a) Electrical Circuit for High Temperature Reverse Bias Burn-in  | N/A |
| 5(b) Electrical Circuit for Power Burn-in and Operating Life Tests | 17  |

**APPENDICES (Applicable to specific Manufacturers only)**

None.

**1. GENERAL****1.1 SCOPE**

This specification details the ratings, physical and electrical characteristics, test and inspection data for a Transistor, High Power, NPN, based on Type 2N5154.

It shall be read in conjunction with ESA/SCC Generic Specification No. 5000, the requirements of which are supplemented herein.

**1.2 COMPONENT TYPE VARIANTS**

Variants of the basic transistors specified herein, which also covered by this specification, are given in Table 1(a).

**1.3 MAXIMUM RATINGS**

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the transistors specified herein, are scheduled in Table 1(b).

**1.4 PARAMETER DERATING INFORMATION**

The derating information applicable to the transistors specified herein is shown in Figure 1.

**1.5 PHYSICAL DIMENSIONS**

The physical dimensions of the transistors specified herein are shown in Figure 2.

**1.6 FUNCTIONAL DIAGRAM**

The functional diagram showing lead identification, of the transistors specified herein, is shown in Figure 3.

**1.7 HIGH TEMPERATURE TEST PRECAUTIONS**

For tin-plated or solder-dipped lead finish, all tests to be performed at a temperature that exceeds +125°C shall be carried out in a 100% inert atmosphere.

**2. APPLICABLE DOCUMENTS**

The following documents form part of this specification and shall be read in conjunction with it:-

- (a) ESA/SCC Generic Specification No. 5000 for Discrete Semiconductor Components.
- (b) MIL-STD-750, Test Methods and Procedures for Semiconductor Devices.

**3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS**

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply.



**TABLE 1(a) - TYPE VARIANTS**

| VARIANT | BASED ON TYPE | CASE  | FIGURE | LEAD MATERIAL AND FINISH |
|---------|---------------|-------|--------|--------------------------|
| 01      | 2N5154        | TO39  | 2(a)   | D2                       |
| 02      | 2N5154        | TO39  | 2(a)   | D3 or D4                 |
| 03      | 2N5154        | TO39  | 2(a)   | D7                       |
| 04      | 2N5154        | TO257 | 2(b)   | H2                       |
| 05      | 2N5154        | TO257 | 2(b)   | H4                       |

**TABLE 1(b) - MAXIMUM RATINGS**

| No. | CHARACTERISTICS   | SYMBOL        | MAXIMUM RATINGS | UNIT               | REMARKS                                     |
|-----|---|---------------|-----------------|--------------------|---|
| 1   | Collector-Base Voltage  | $V_{CBO}$     | 100             | V                  |   |
| 2   | Collector-Emitter Voltage                                     | $V_{CEO}$     | 80              | V                  |   |
| 3   | Emitter-Base Voltage  | $V_{EBO}$     | 6.0             | V                  |   |
| 4   | Collector Current (Continuous)                                | $I_C$         | 5.0             | A                  |   |
| 5   | Base Current (Continuous)                                     | $I_B$         | 1.0             | A                  |   |
| 6   | Power Dissipation 1<br>Variants 01 to 03<br>Variants 04 to 05 | $P_{tot1}$    | 1.0<br>3.3      | W                  | $T_{amb} \leq +25^\circ\text{C}$<br>Note 1  |
| 7   | Power Dissipation 2<br>Variants 01 to 03<br>Variants 04 to 05 | $P_{tot2}$    | 8.75<br>35      | W                  | $T_{case} \leq +25^\circ\text{C}$<br>Note 1 |
| 8   | Operating Temperature Range                                   | $T_{op}$      | - 65 to +200    | $^\circ\text{C}$   | $T_{amb}$ or $T_{case}$                     |
| 9   | Storage Temperature Range                                     | $T_{stg}$     | - 65 to +200    | $^\circ\text{C}$   |   |
| 10  | Soldering Temperature   | $T_{sol}$     | +260            | $^\circ\text{C}$   | Note 2                                      |
| 11  | Thermal Resistance<br>Variants 01 to 03<br>Variants 04 to 05  | $R_{TH(J-C)}$ | 20<br>5.0       | $^\circ\text{C/W}$ |   |

**NOTES**

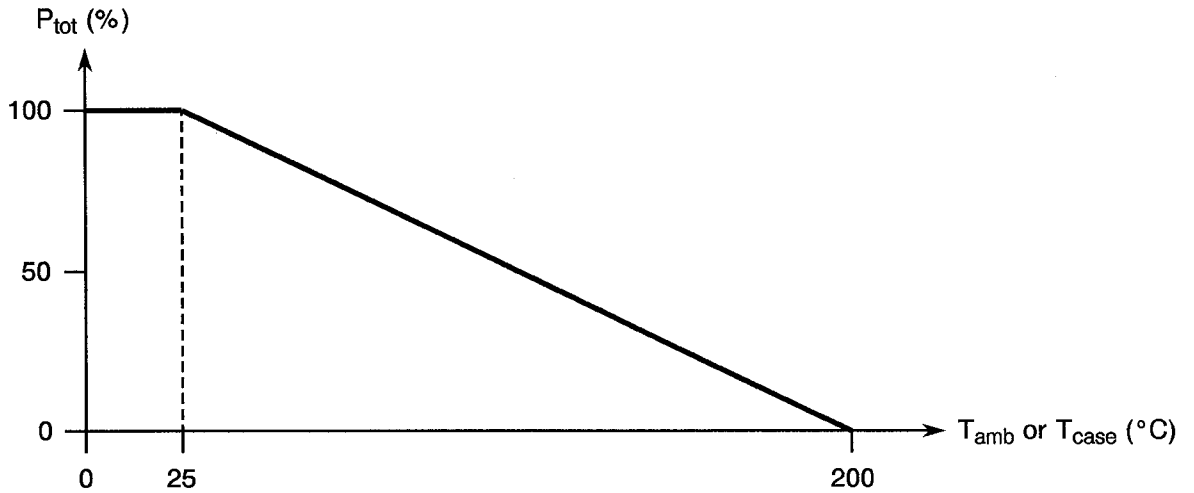
1. For derating at  $T_{amb}$  or  $T_{case} > +25^\circ\text{C}$ , see Figure 1.
2. Duration 10 seconds maximum at a distance of not less than 1.5mm from the device body and the same lead shall not be resoldered until 3 minutes have elapsed.



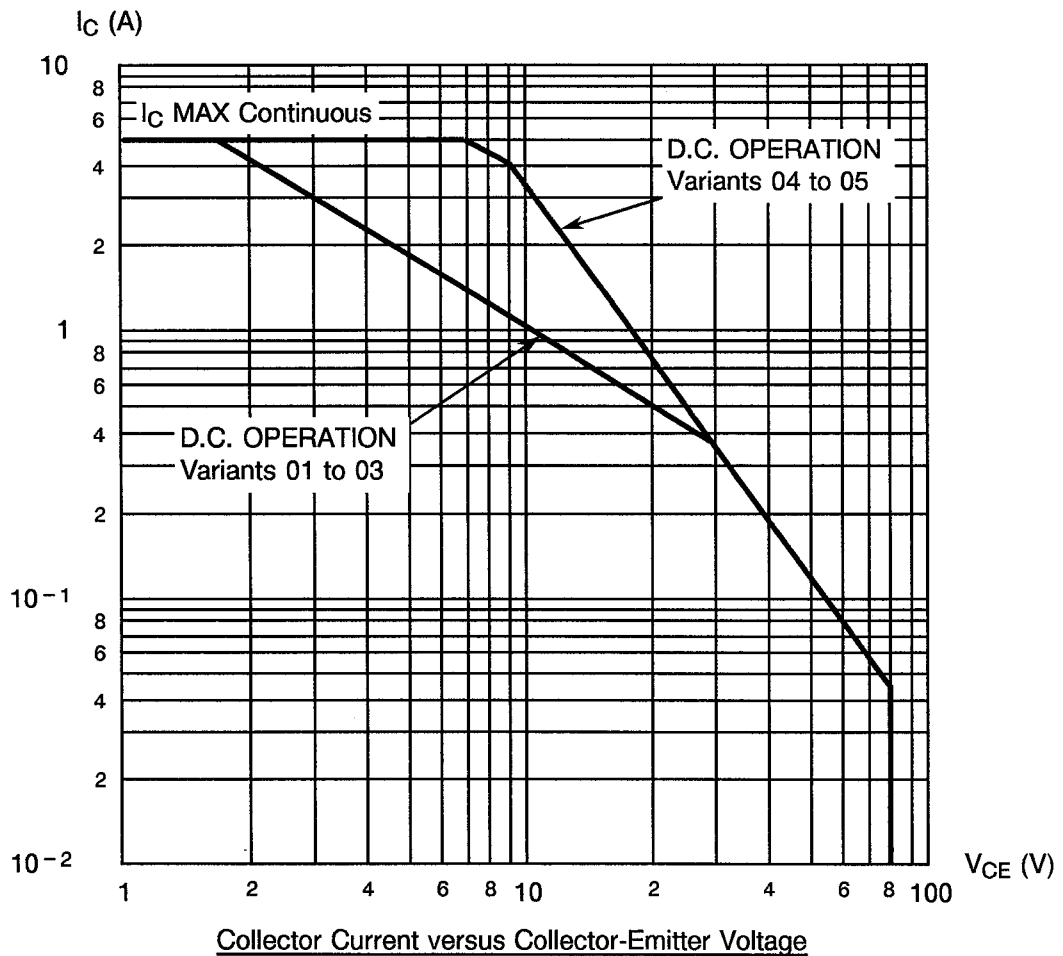


**FIGURE 1 - PARAMETER DERATING INFORMATION**

**FIGURE 1(a) - POWER DISSIPATION VERSUS TEMPERATURE**



**FIGURE 1(b) - FORWARD BIAS SAFE OPERATING AREA (MAXIMUM CONTINUOUS D.C.)**



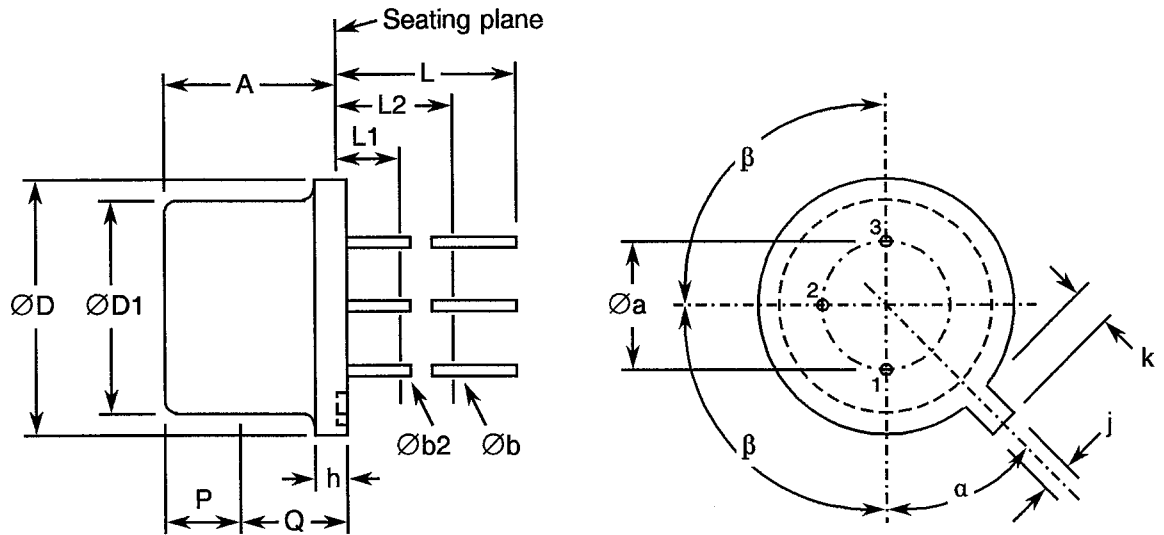
**NOTES**

1. See Para. 4.7.6.



**FIGURE 2 - PHYSICAL DIMENSIONS**

**FIGURE 2(a) - VARIANTS 01 to 03**



| SYMBOL           | MILLIMETRES |       | NOTES |
|------------------|-------------|-------|-------|
|                  | MIN.        | MAX.  |       |
| $\varnothing a$  | 4.83        | 5.33  |       |
| A                | 6.10        | 6.60  |       |
| $\varnothing b$  | 0.406       | 0.533 | 2     |
| $\varnothing b2$ | 0.406       | 0.483 | 2     |
| $\varnothing D$  | 8.89        | 9.40  |       |
| $\varnothing D1$ | 8.00        | 8.51  |       |
| h                | 0.229       | 3.18  |       |
| j                | 0.711       | 0.864 |       |
| k                | 0.737       | 1.02  | 3     |
| L                | 12.70       | -     | 2     |
| L1               | -           | 1.27  | 2     |
| L2               | 6.35        | -     | 2     |
| P                | 2.54        | -     | 1     |
| Q                | -           | -     | 4     |
| $\alpha$         | 45° NOM.    |       |       |
| $\beta$          | 90° NOM.    |       |       |

**NOTES**

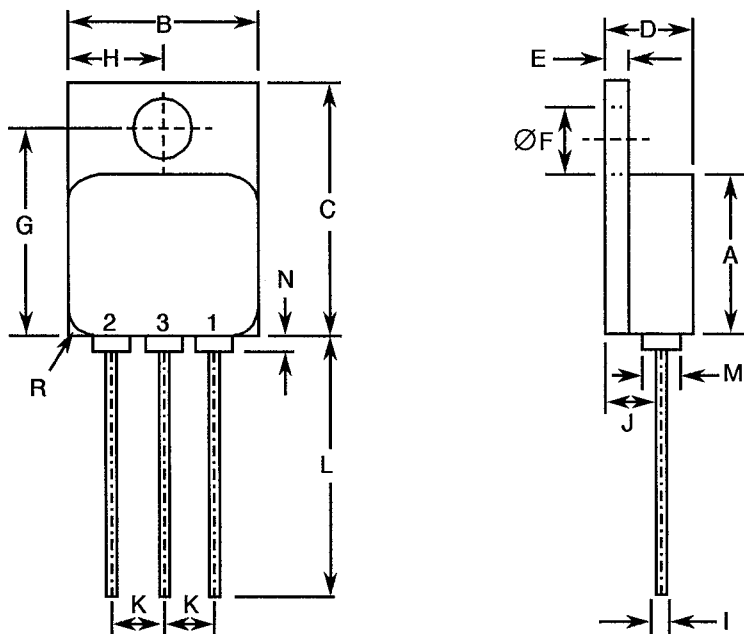
1. This zone is controlled for automatic handling. The variation in actual diameter within this zone shall not exceed 0.254mm.
2. 3 leads. Dimension  $\varnothing b2$  applies between L1 and L2. Dimension  $\varnothing b$  applies between L2 and 12.70mm from the seating plane. Diameter is uncontrolled in L1 and beyond 12.70mm from the seating plane.
3. Measured from maximum diameter of the actual device.
4. Details of outline in this zone is optional.



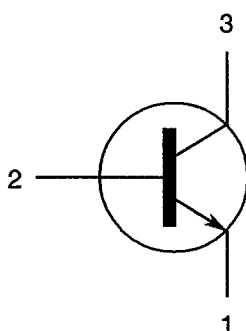
**FIGURE 2 - PHYSICAL DIMENSIONS (CONT.)**

**FIGURE 2(b) - VARIANTS 04 to 05**

| SYMBOL | MILLIMETRES  |       |
|--------|--------------|-------|
|        | MIN.         | MAX.  |
| A      | 10.41        | 10.67 |
| B      | 10.41        | 10.67 |
| C      | 16.51        | 16.76 |
| D      | 4.7          | 5.33  |
| E      | 0.89         | 1.14  |
| ØF     | 3.56         | 3.81  |
| G      | 13.39        | 13.64 |
| H      | 5.13         | 5.38  |
| I      | 0.64         | 0.89  |
| J      | 2.92         | 3.18  |
| K      | 2.41         | 2.67  |
| L      | 15.24        | 16.51 |
| M      | 2.29 Typical |       |
| N      | -            | 0.71  |
| R      | 1.65 Typical |       |



**FIGURE 3 - FUNCTIONAL DIAGRAM**



- 1. Emitter.
- 2. Base.
- 3. Collector.

**NOTES**

- 1. For Variants 01 to 03, the collector is internally connected to the case.
- 2. For Variants 04 to 05, the collector is isolated from the case.

**4. REQUIREMENTS****4.1 GENERAL**

The complete requirements for procurement of the transistors specified herein are stated in this specification and ESA/SCC Generic Specification No. 5000. Deviations from the Generic Specification, applicable to this specification only, are listed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

**4.2 DEVIATIONS FROM GENERIC SPECIFICATION****4.2.1 Deviations from Special In-process Controls**

None.

**4.2.2 Deviations from Final Production Tests (Chart II)**

None.

**4.2.3 Deviations from Burn-in and Electrical Measurements (Chart III)**

(a) Para. 7.1.1(a), "High Temperature Reverse Bias" test and subsequent electrical measurements related to this test shall be omitted.

**4.2.4 Deviations from Qualification Tests (Chart IV)**

None.

**4.2.5 Deviations from Lot Acceptance Tests (Chart V)**

None.

**4.3 MECHANICAL REQUIREMENTS****4.3.1 Dimension Check**

The dimensions of the transistors specified herein shall be checked. They shall conform to those shown in Figure 2.

**4.3.2 Weight**

The maximum weight of the transistors specified herein shall be 1.5 grammes for Variants 01 to 03 and 5.0 grammes for Variants 04 to 05.

**4.3.3 Terminal Strength**

The requirements for terminal strength testing are specified in Section 9 of ESA/SCC Generic Specification No. 5000. The test conditions shall be as follows:-

**Variants 01 to 03**

Test Condition : 'E' Lead Fatigue.

**Variants 04 to 05**

Test Condition : 'A' (Tension).

Applied Force : 10 N.

Duration : 10 seconds.



4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the transistors specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

4.4.1 Case

For Variants 01 to 03, the case shall be hermetically sealed and have a metal body with hard glass seals and the lid shall be welded, brazed, preform soldered or glass frit sealed.

For Variants 04 to 05, the case shall be hermetically sealed and have a metal body, the Fe/Ni copper core pin shall pass through a ceramic eyelet brazed into the frame and the lid shall be welded.

4.4.2 Lead Material and Finish

For Variants 01 to 03, the lead material shall be Type 'D' with either Type '2', Type '3 or 4' or Type '7' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500. (See Table 1(a) for Type Variants).

For Variants 04 to 05, the lead material shall be Type 'H' with either Type '2' or Type '4' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500. (See Table 1(a) for Type Variants).

4.5 MARKING

4.5.1 General

The marking of all components delivered to this specification shall be in accordance with the requirements of ESA/SCC Basic Specification No. 21700 and the following paragraphs. When the component is too small to accommodate all of the marking specified, as much as space permits shall be marked and the marking information, in full, shall accompany the component in its primary package.

The information to be marked and the order of precedence, shall be as follows:-

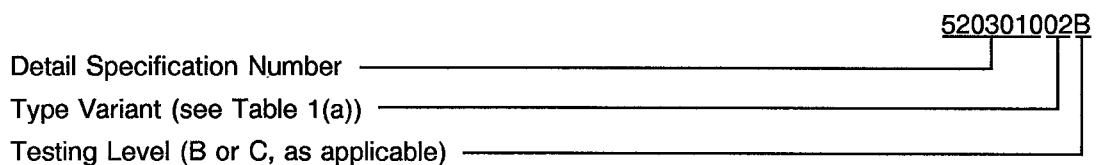
- (a) Lead Identification.
- (b) The SCC Component Number.
- (c) Traceability Information.

4.5.2 Lead Identification

Lead identification shall be as shown in Figures 2 and 3.

4.5.3 The SCC Component Number

Each component shall bear the SCC Component Number which shall be constituted and marked as follows:-





#### 4.5.4 Traceability Information

Each component shall be marked in respect of traceability information in accordance with the requirements of ESA/SCC Basic Specification No. 21700.

#### 4.6 ELECTRICAL MEASUREMENTS

##### 4.6.1 Electrical Measurements at Room Temperature

The parameters to be measured at room temperature are scheduled in Table 2. Unless otherwise stated, the measurements shall be performed at  $T_{amb} = +22 \pm 3$  °C.

##### 4.6.2 Electrical Measurements at High and Low Temperatures

The parameters to be measured at high and low temperatures are scheduled in Table 3.

##### 4.6.3 Circuits for Electrical Measurements

Circuits for use in performing the electrical measurements listed in Table 2 of this specification are shown in Figure 4.

#### 4.7 BURN-IN TESTS

##### 4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Unless otherwise stated, measurements shall be performed at  $T_{amb} = +22 \pm 3$  °C. The parameter drift values ( $\Delta$ ) applicable to the parameters scheduled shall not be exceeded. In addition to these drift value requirements, the appropriate limit value specified for a given parameter in Table 2 shall not be exceeded.

##### 4.7.2 Conditions for High Temperature Reverse Bias Burn-in (Table 5(a))

Not applicable.

##### 4.7.3 Conditions for Power Burn-in

The requirements for power burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 5000. The conditions for power burn-in shall be as specified in Table 5(b) of this specification.

##### 4.7.4 Electrical Circuit for High Temperature Reverse Bias Burn-in (Figure 5(b))

Not applicable.

##### 4.7.5 Electrical Circuit for Power Burn-in

A circuit for use in performing the power burn-in tests is shown in Figure 5(b) of this specification.

##### 4.7.6 Verification of Safe Operating Area

The requirement for the verification of the Safe Operating Area are specified in Section 9 of ESA/SCC Generic Specification No. 5000. The test method shall be as follows:-

Maximum continuous d.c. in accordance with MIL-STD-750, Method 3052 and Figure 1(b) of this specification, at  $T_{case} = +25$  °C and for an operating time of 100ms maximum.

For Variants 01 to 05:  $I_C = 0.35A$ ,  $V_{CE} = 25V$ .



**TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE - d.c. PARAMETERS**

| No. | CHARACTERISTICS                           | SYMBOL         | MIL-STD-750<br>TEST METHOD | TEST CONDITIONS                                | LIMITS |      | UNIT    |
|-----|---|----------------|----------------------------|--|--------|------|---------|
|     |   |                |                            |  | MIN    | MAX  |         |
| 1   | Collector-Emitter<br>Breakdown Voltage    | $V_{(BR)CEO}$  | 3011                       | $I_C = 100mA$<br>$I_B = 0A$<br>Note 1          | 80     | -    | V       |
| 2   | Collector-Emitter<br>Cut-off Current      | $I_{CES}$      | 3041                       | $V_{CE} = 60V$<br>$V_{BE} = 0V$                | -      | 1.0  | $\mu A$ |
| 3   | Collector-Emitter<br>Cut-off Current      | $I_{CEO}$      | 3041                       | $V_{CE} = 40V$<br>$I_B = 0A$                   | -      | 50   | $\mu A$ |
| 4   | Emitter-Base<br>Cut-off Current 1         | $I_{EBO1}$     | 3061                       | $V_{EB} = 5.0V$<br>$I_C = 0A$                  | -      | 1.0  | $\mu A$ |
| 5   | Emitter-Base<br>Cut-off Current 2         | $I_{EBO2}$     | 3061                       | $V_{EB} = 6.0V$<br>$I_C = 0A$                  | -      | 1.0  | mA      |
| 6   | D.C. Forward Current<br>Transfer Ratio 1  | $h_{FE1}$      | 3076                       | $V_{CE} = 5.0V$<br>$I_C = 50mA$<br>Note 1      | 50     | -    | -       |
| 7   | D.C. Forward Current<br>Transfer Ratio 2  | $h_{FE2}$      | 3076                       | $V_{CE} = 5.0V$<br>$I_C = 2.5A$<br>Note 1      | 70     | 200  | -       |
| 8   | D.C. Forward Current<br>Transfer Ratio 3  | $h_{FE3}$      | 3076                       | $V_{CE} = 5.0V$<br>$I_C = 5.0A$<br>Note 1      | 40     | -    | -       |
| 9   | Collector-Emitter<br>Saturation Voltage 1 | $V_{CE(SAT)1}$ | 3071                       | $I_C = 5.0A$<br>$I_B = 0.5A$<br>Notes 1 and 2  | -      | 1.5  | V       |
| 10  | Collector-Emitter<br>Saturation Voltage 2 | $V_{CE(SAT)2}$ | 3071                       | $I_C = 2.5A$<br>$I_B = 0.25A$<br>Notes 1 and 2 | -      | 1.45 | V       |
| 11  | Base-Emitter<br>Saturation Voltage 1      | $V_{BE(SAT)1}$ | 3066                       | $I_C = 2.5A$<br>$I_B = 0.25A$<br>Notes 1 and 2 | -      | 1.45 | V       |
| 12  | Base-Emitter<br>Saturation Voltage 2      | $V_{BE(SAT)2}$ | 3066                       | $I_C = 5.0A$<br>$I_B = 0.5A$<br>Notes 1 and 2  | -      | 2.2  | V       |

**NOTES**

1. Pulsed measurement: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2.0\%$ .
2. Saturation voltages measured 6.0mm from header.

**TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE - a.c. PARAMETERS**

| No. | CHARACTERISTICS                        | SYMBOL    | MIL-STD-750<br>TEST METHOD | TEST<br>FIG. | TEST CONDITIONS<br>(NOTE 1)  | LIMITS |     | UNIT    |
|-----|--|-----------|----------------------------|--------------|--|--------|-----|---------|
|     |  |           |                            |              |  | MIN    | MAX |         |
| 13  | A.C. Forward Current<br>Transfer Ratio | $h_{fe}$  | 3206                       | -            | $V_{CE} = 5.0$<br>$I_C = 0.5A$<br>$f = 20MHz$  | 3.5    | -   | -       |
| 14  | Output Capacitance                     | $C_{obo}$ | 3236                       | -            | $V_{BE} = 10V$<br>$I_C = 0A$<br>$f = 1.0MHz$   | -      | 250 | pF      |
| 15  | Turn-on Time                           | $t_{on}$  | -                          | 4            | $I_C = 5.0A$<br>$I_{B1} = 0.5A$<br>$I_{B2} = -0.5A$<br>$V_{BB} = -4.0V$<br>$V_{CC} = 30V$<br>$V_{IN} \approx +51V$ | -      | 0.5 | $\mu s$ |
| 16  | Turn-off Time                          | $t_{off}$ | -                          | 4            | $I_C = 5.0A$<br>$I_{B1} = 0.5A$<br>$I_{B2} = -0.5A$<br>$V_{BB} = -4.0V$<br>$V_{CC} = 30V$<br>$V_{IN} \approx +51V$ | -      | 1.3 | $\mu s$ |

**NOTES**

- Measurements shall be performed on a sample basis, LTPD7.

**TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES**

| No. | CHARACTERISTICS                          | SYMBOL    | MIL-STD-750<br>TEST METHOD | TEST CONDITIONS  | LIMITS |     | UNIT    |
|-----|--|-----------|----------------------------|--|--------|-----|---------|
|     |  |           |                            |  | MIN    | MAX |         |
| 2   | Collector-Emitter<br>Cut-off Current     | $I_{CES}$ | 3041                       | $V_{CE} = 60V$<br>$V_{BE} = 0V$<br>$T_{amb} = +150\text{ }^\circ C$          | -      | 10  | $\mu A$ |
| 7   | D.C. Forward Current<br>Transfer Ratio 2 | $h_{FE2}$ | 3076                       | $V_{CE} = 5.0V$<br>$I_C = 2.5A$<br>$T_{amb} = -55\text{ }^\circ C$<br>Note 1 | 35     | -   | -       |

**NOTES**

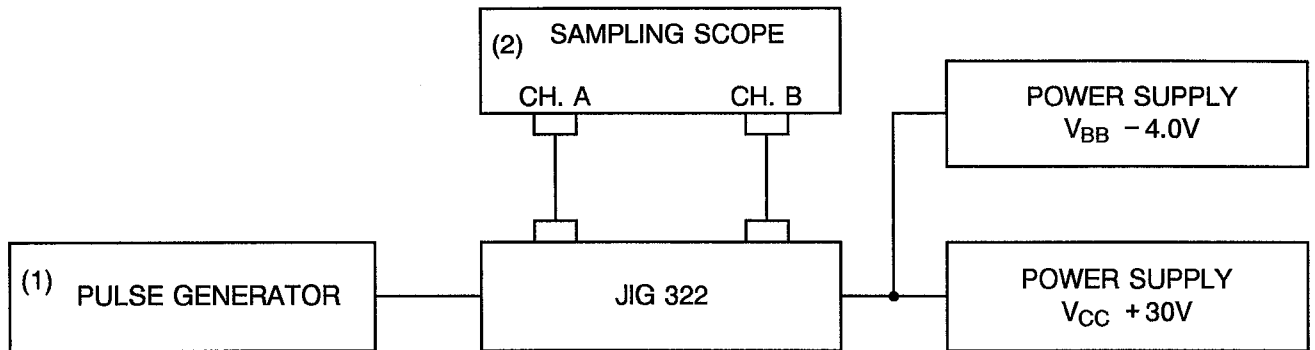
- Pulsed measurement: Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2.0\%$ .



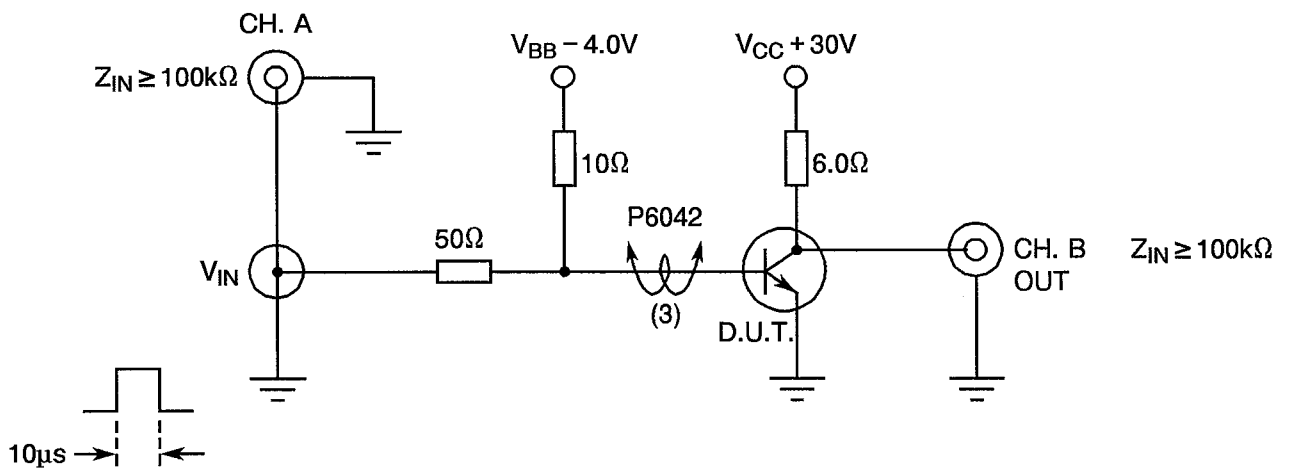


**FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS**

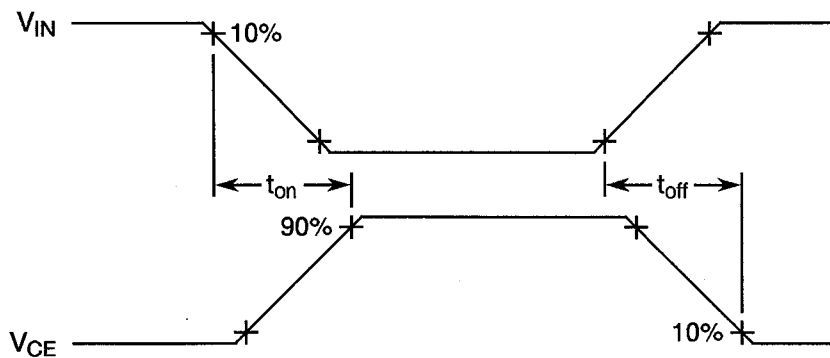
BLOCK DIAGRAM



EQUIVALENT TEST CIRCUIT



VOLTAGE WAVEFORMS



**NOTES**

1. Pulse generator Type EH132 or equivalent,  $t_r \leq 20ns$ ,  $t_p = 10\mu s$ , Duty Cycle = 1.0%.
2. Sampling Scope Tetrioniks 568 or equivalent.
3. Adjust  $V_{IN} - V_B$  with current probe P6042.

**TABLE 4 - PARAMETER DRIFT VALUES**

| No. | CHARACTERISTICS                        | SYMBOL         | SPEC. AND/OR TEST METHOD | TEST CONDITIONS | CHANGE LIMITS ( $\Delta$ ) | UNIT |
|-----|--|----------------|--------------------------|-----------------|----------------------------|------|
| 2   | Collector-Emitter Cut-off Current      | $I_{CES}$      | As per Table 2           | As per Table 2  | $\pm 100$                  | nA   |
| 7   | D.C. Forward Current Transfer Ratio 2  | $h_{FE2}$      | As per Table 2           | As per Table 2  | $\pm 25$                   | %    |
| 9   | Collector-Emitter Saturation Voltage 1 | $V_{CE(SAT)1}$ | As per Table 2           | As per Table 2  | $\pm 100$                  | mV   |

**TABLE 5(a) - CONDITIONS FOR HIGH TEMPERATURE REVERSE BIAS BURN-IN**

Not applicable.

**TABLE 5(b) - CONDITIONS FOR POWER BURN-IN AND OPERATING LIFE TESTS**VARIANTS 01 TO 03

| No. | CHARACTERISTICS           | SYMBOL     | CONDITIONS  | UNIT        |
|-----|---------------------------|------------|---|-------------|
| 1   | Ambient Temperature       | $T_{amb}$  | + 20 to + 50 (1)  | $^{\circ}C$ |
| 2   | Power Dissipation 1       | $P_{tot1}$ | Maximum rating at $T_{amb}$ according to derating curve (See Figure 1(a)) | W           |
| 3   | Collector-Emitter Voltage | $V_{CE}$   | 20  | V           |

**NOTES**

1. No heat sink forced air directly on the device shall be permitted.

VARIANTS 04 TO 05

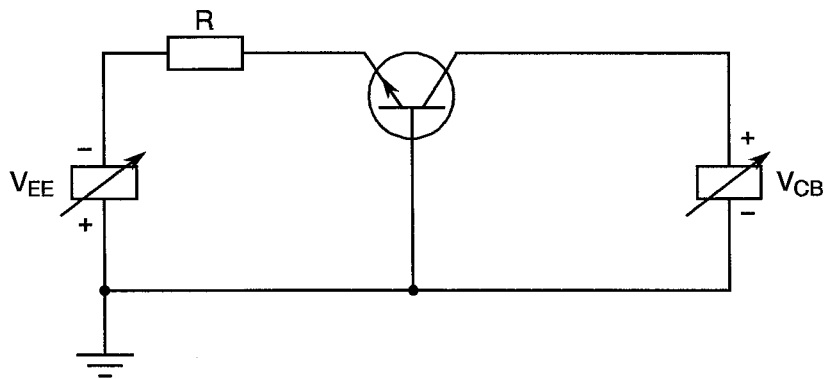
| No. | CHARACTERISTICS           | SYMBOL     | CONDITIONS  | UNIT        |
|-----|---------------------------|------------|---|-------------|
| 1   | Case Temperature          | $T_{case}$ | + 100(+ 0 - 5)  | $^{\circ}C$ |
| 2   | Power Dissipation 2       | $P_{tot2}$ | Maximum rating at $T_{amb}$ according to derating curve (See Figure 1(a)) | W           |
| 3   | Collector-Emitter Voltage | $V_{CE}$   | 20  | V           |



**FIGURE 5(a) - ELECTRICAL CIRCUIT FOR HIGH TEMPERATURE REVERSE BIAS BURN-IN**

Not applicable.

**FIGURE 5(b) - ELECTRICAL CIRCUIT FOR POWER BURN-IN AND OPERATING LIFE TESTS**





- 4.8 ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC GENERIC SPECIFICATION NO. 5000)
- 4.8.1 Electrical Measurements on Completion of Environmental Tests  
The parameters to be measured on completion of environmental tests are scheduled in Table 2. Unless otherwise stated, the measurements shall be performed at  $T_{amb} = +22 \pm 3 \text{ }^{\circ}\text{C}$ .
- 4.8.2 Electrical Measurements at Intermediate Points and on Completion of Endurance Tests  
The parameters to be measured at intermediate points and on completion of endurance testing are scheduled in Table 6 of this specification. Unless otherwise stated, the measurements shall be performed at  $T_{amb} = +22 \pm \text{ }^{\circ}\text{C}$ .
- 4.8.3 Conditions for Operating Life Tests (Part of Endurance Testing)  
The requirements for operating life testing are specified in Section 9 of ESA/SCC Generic Specification No. 5000. The conditions for operating life testing shall be the same as specified in Table 5(b) for the power burn-in test.
- 4.8.4 Electrical Circuit for Operating Life Tests  
The electrical circuit for performing the operating life test is the same as that shown in Figure 5(b) for power burn-in.
- 4.8.5 Conditions for High Temperature Storage Test (Part of Endurance Testing)  
The requirements for the high temperature storage test are specified in ESA/SCC Generic Specification No. 5000. The temperature to be applied shall be the maximum storage temperature specified in Table 1(b) of this specification.



**TABLE 6 - ELECTRICAL MEASUREMENTS AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING**

| No. | CHARACTERISTICS                        | SYMBOL         | SPEC. AND/OR TEST METHOD | TEST CONDITIONS | LIMITS |      | UNIT    |
|-----|--|----------------|--------------------------|-----------------|--------|------|---------|
|     |  |                |                          |                 | MIN.   | MAX. |         |
| 2   | Collector-Emitter Cut-off Current      | $I_{CES}$      | As per Table 2           | As per Table 2  | -      | 1.0  | $\mu A$ |
| 7   | D.C. Forward Current Transfer Ratio 2  | $h_{FE2}$      | As per Table 2           | As per Table 2  | 70     | 200  | -       |
| 9   | Collector-Emitter Saturation Voltage 1 | $V_{CE(SAT)1}$ | As per Table 2           | As per Table 2  | -      | 1.5  | V       |